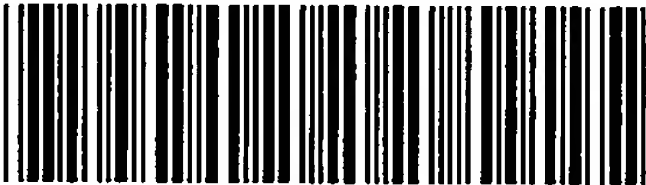


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/633,344	LAM ET AL.	
	Examiner	Art Unit	
	Tuan V. Thai	2186	

SEARCHED			
Class	Subclass	Date	Examiner
711	100	7/18/2006	TH
711	154	7/18/2006	TH
711	161	7/18/2006	TH
711	162	7/18/2006	TH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
711	162	7/18/2006	TH
711	161	7/18/2006	TH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST searches: USPGPUB EPO/JPO abstr DERWENTS IBMTDB NORTH database NPL search IEEE database	7/18/2006	TH